Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/052,966	LIM ET AL.
Examiner	Art Unit
Lakehmi S. Channavaijala	1615

	SEARCHED			
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Structure searc- attached, STN - registry and CAPLUS, discussed with celia chang, Primary Examiner 1625	9/26/2006	LС
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